## Amendments to the Claims

This listing of claims will replace all prior versions, and listings, of claims in the application:

## <u>Listing of Claims</u>:

- 1. (Original) An electrode substrate comprising a substrate, a lower electrode, an insulating film having a liquid-repellent region and a liquid-attracting region on a surface thereof and an upper electrode, wherein the lower electrode, the insulating film and the upper electrode are layered in this order on the substrate; wherein a pattern shape of the lower electrode generally matches with that of the liquid-repellent region on the surface of the insulating film; and wherein the upper electrode is formed mainly on the liquid-attracting region excluding the liquid-repellent region on the surface of the insulating film, such that the pattern shape of the upper electrode is a self-aligned shape in which the pattern shape of the lower electrode is generally reversed.
- 2. (Original) A thin film transistor comprising the electrode substrate according to claim 1 and a semiconductor film, wherein, on the electrode substrate, a gate electrode is formed as the lower electrode, and a source electrode and a drain electrode are formed as the upper electrodes on the respective liquid-attracting regions isolated into two or more regions by the liquid-repellent region formed on the surface of the insulating film in a pattern shape that generally matches with the lower electrode, such that the pattern shape of the upper electrodes is a self-aligned shape in which the pattern shape of the gate electrode, i.e., the lower electrode, is generally reversed; and wherein the semiconductor film is formed such that it extends over and covers at least a part of each of the source electrode, the drain electrode and the surface of the insulating film (gate electrode region) lying therebetween over/on said electrode substrate.

- 3. (Original) An active matrix thin film transistor substrate comprising the electrode substrate according to claim 1 and thin film transistors having semiconductor films, wherein, on the electrode substrate, a plurality of gate wirings/electrodes is formed as the lower electrodes, and a plurality of signal wirings, source/drain electrodes and pixel electrodes are formed as the upper electrodes on the liquid-attracting regions isolated into a plurality of regions by the liquid-repellent regions formed on the surface of the insulating film in a pattern shape that generally matches with the lower electrodes; wherein the semiconductor films are formed such that they extend over and cover at least a part of each of the source electrodes, drain electrodes and liquid-repellent regions (gate wiring/electrode regions) on the surface of the insulating films lying therebetween over/on the electrode substrate; and wherein the thin film transistors are each placed at each intersection of the gate wiring and signal wiring.
- 4. (Original) The active matrix thin film transistor substrate according to claim 3, wherein a plurality of gate wirings/electrodes, having a shape in which a plurality of adjacently placed ring-shaped rectangles each having an opening are connected to each other at least at one or more locations, are adjacently placed to each other as the lower electrodes; wherein signal wirings and source/drain electrodes are each formed on the space between said rectangles in a continuous shape spreading over the connection in a self-aligned manner with respect to said gate wirings/electrodes as the upper electrodes; and wherein the pixel electrodes are each formed in an opening of said ring-shaped rectangle.
- 5. (Original) The active matrix thin film transistor substrate according to claim 4, wherein a width of the connection part for connecting each of a plurality of rectangles each having an opening for composing gate wirings/electrodes and a width of a space between a plurality of gate wirings/electrodes are smaller than a width of a space between a plurality of rectangles each having an opening for composing gate wirings/electrodes.

- 6. (Original) A liquid crystal, electrophoresis, or organic electroluminescent display device, which comprises the thin film transistor substrate according to any one of claims 3 to 5 as an active matrix switch.
- 7. (Original) An RFID device, which comprises the thin film transistor according to claim 2 as at least a part thereof.
- 8. (Original) The electrode substrate, thin film transistor and active matrix thin film transistor substrate according to any one of claims 1 to 3, which comprises a photosensitive liquid-repellent monolayer comprising a carbon chain in which at least a part thereof is terminated with fluorine or hydrogen as a photosensitive liquid-repellent film.

## 9-10. (Cancelled).

- 11. (Currently Amended) The electrode substrate, thin film transistor, and active matrix thin film transistor substrate according to claim 1 any one of claims 1 to 5, wherein at least one of the substrate and the insulating film is formed by a material that does not transmit a light with a photosensitive wavelength of the photosensitive liquid-repellent film.
- 12. (New) The thin film transistor according to claim 2, wherein at least one of the substrate and the insulating film is formed by a material that does not transmit a light with a photosensitive wavelength of the photosensitive liquid-repellent film.
- 13. (New) The active matrix thin film transistor substrate according to any one of claims 3 to 5, wherein at least one of the substrate and the insulating film is formed by a material that does not transmit a light with a photosensitive wavelength of the photosensitive liquid-repellent film.